

CoolGaN™ BDS 650 V G5

TOLT

CoolGaN™ Bi-directional switch, enhancement-mode

Infineon's CoolGaN™ Bi-Directional Switch (BDS) is an innovative solution in gallium nitride (GaN) transistor technology. The CoolGaN™ BDS 650 V G5 enables efficient voltage blocking in both directions, making it a versatile option for a wide range of applications. The CoolGaN™ BDS monolithically integrates a substrate voltage control circuit, thanks to Infineon's proprietary technology: this reduces design complexity. IGLT65R055B2 is offered in Infineon's TOLT, top-side cooling package specially designed to enable the highest power densities for power-demanding industrial applications.

Features

- 650 V CoolGaN™ technology with 850 V_{SS} surge immunity
- Superior rugged Gate Injection Transistor (GIT) structure
- Dual-gate for independent bi-directional functionality
- Superior performance of R_{SS(on)} over operating frequency
- Reliable Thermal Cycling on-Board (TCOB) performance
- Optimized for soft switching operation
- 2 kV HBM ESD standard

Benefits

- Effective replacement of back-to-back uni-directional products
- Improves system efficiency and power density
- Enables higher switching frequency
- System cost reduction
- Enables new single stage isolated topologies

Potential applications

- Cycloconverter in solar μ-inverter
- Vienna type rectifier in industrial/server SMPS and UPS
- T-type PFC, inverter in motor drives
- HERIC Inverter in string solar inverter

Product validation

Fully qualified according to JEDEC for Industrial Applications

Please note: Preliminary Datasheet to change without further notice.

Please note: The substrate thermal pad is for thermal coupling only, it should be electrically isolated from any electrical node in the system via isolation material.

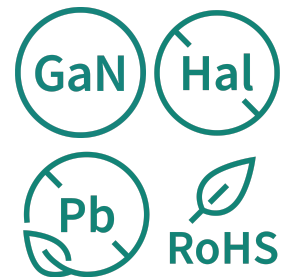
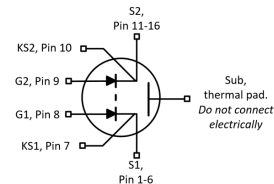
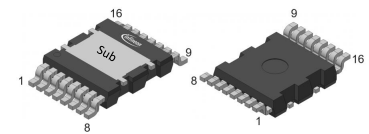


Table 1 Key performance parameters

Parameter	Value	Unit
V _{SS,cont}	340	V _{AC}
R _{SS(on),typ}	55	mΩ
Q _{GxSx,diode}	5.4	nC
I _{SS,pulse}	±73	A
Q _{oss} @ 400 V _{SS} (switch)	72	nC

Part number	Package	Marking	Related links
IGLT65R055B2	PG-HDSOP-16	65R055B2	see Appendix A

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1 Maximum ratings

at $T_j = 25^\circ\text{C}$, unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact your local Infineon sales office.

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Source-to-source voltage, continuous	$V_{SS,cont}$	-	-	340	V_{AC}	$V_{GS}=0\text{ V}$
Source-to-source voltage, transient	$V_{SS,trans}$	-650	-	650	V	$t_{TRANS}=5\text{ ms}$; $V_{GS}=0\text{ V}$
Source-to-source voltage, surge	$V_{SS,surge}$	-850	-	850	V	$t_{SURGE}=1\text{ }\mu\text{s}$; $V_{GS}=0\text{ V}$
Source-to-source AC line frequency	f_{SS}	45	-	-	Hz	$V_{SS}=305\text{ V}_{AC}$; $\pm 431\text{ V}_{pk}$
RMS current, source-to-source	$I_{SS,RMS}$	-21.8	-	21.8	A	$T_C=25^\circ\text{C}$;
		-14		14		$T_C=125^\circ\text{C}$; $T_j=T_{j,max}$
Pulsed current, source-to-source	$I_{SS,pulse}$	-73.6	-	73.6	A	$T_j=25^\circ\text{C}$; $I_{GS}=30.0\text{ mA}$
		-45		45		$T_j=125^\circ\text{C}$; $I_{GS}=30.0\text{ mA}$
Gate current, steady state (single gate)	$I_{G,ss}$	-	-	30.0	mA	$T_j=-40^\circ\text{C}$ to $T_j=150^\circ\text{C}$; see Table 8
Gate current, pulsed (single gate) ¹⁾	$I_{G,pulse}$	-	-	3000	mA	$T_j=-40^\circ\text{C}$ to $T_j=150^\circ\text{C}$; $t_{PULSE}=50\text{ ns}$, $f=100\text{ kHz}$; see Table 8
Gate source voltage, continuous ¹⁾	V_{GS}	-10	-	-	V	$T_j=-40^\circ\text{C}$ to $T_j=150^\circ\text{C}$; see Table 8
Gate source voltage, pulsed ¹⁾	$V_{GSx,pulse}$	-25	-	-	V	$T_j=-40^\circ\text{C}$ to $T_j=150^\circ\text{C}$; $t_{PULSE}=50\text{ ns}$, $f=100\text{ kHz}$; open source
Power dissipation	P_{tot}	-	-	135	W	$T_C=25^\circ\text{C}$
Operating junction temperature	T_j	-40	-	150	$^\circ\text{C}$	$T_j=125^\circ\text{C}$; $V_{GSy}=3\text{ V}$; see Diagram 5, 6
Storage temperature	T_{stg}	-40	-	150	$^\circ\text{C}$	Max shelf life depends on storage conditions
Source-to-source voltage slew-rate	dv/dt	-	-	20	V/ns	-

¹⁾ We recommend using an advanced driving technique to optimize the device performance. Please see gate drive application note for more details.

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	0.92	°C/W	-
Thermal resistance, junction - ambient	R_{thJA}	-	-	TBD	°C/W	Device on PCB, minimum footprint
Thermal resistance, junction - ambient for SMD version	R_{thJA}	-	-	TBD	°C/W	Device on 40 mm*40 mm*1.5 mm epoxy PCB FR4 with 6 cm ² (one layer, 70 μm thickness) copper area. PCB is vertical without air stream cooling.
Reflow soldering temperature	T_{sold}	-	-	260	°C	reflow MSL3

3 Electrical characteristics

at $T_j=25^\circ\text{C}$, unless specified otherwise

Table 4 Gate characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate threshold voltage: switch mode (OFF) to diode mode	$V_{GxSx(th), diode}$	0.8	1.15	1.6	V	$I_{SS}=3.0\text{ mA}$; $V_{GySy}=0\text{ V}$; $V_{SS}=10\text{ V}$; $T_j=25^\circ\text{C}$;
		-	0.95	-		$I_{SS}=3.0\text{ mA}$; $V_{GySy}=0\text{ V}$; $V_{SS}=10\text{ V}$; $T_j=125^\circ\text{C}$; see Table 9
Gate threshold voltage: diode mode to switch mode (ON)	$V_{GxSx(th), switch}$	0.7	1.00	1.5	V	$I_{SS}=3.0\text{ mA}$; $I_{GySy}=5\text{ mA}$; $V_{SS}=10\text{ V}$; $T_j=25^\circ\text{C}$;
		-	0.83	-		$I_{SS}=3.0\text{ mA}$; $I_{GySy}=5\text{ mA}$; $V_{SS}=10\text{ V}$; $T_j=125^\circ\text{C}$; see Table 9
Gate-Source reverse clamping voltage	$V_{GS, clamp}$	-8	-	-	V	$I_{GS,ss}=-1\text{ mA}$
Gate charge: diode mode to switch mode (ON)	$Q_{GxSx, switch}$	-	5.4	-	nC	$V_{GxSx}=0\text{ to }3\text{ V}$; $I_{GySy}=5\text{ mA}$; $V_{SS}=400\text{ V}$, $I_{SS}=9\text{ A}$
Gate resistance	$R_{GS, int}$	-	1	-	Ω	LCR impedance measurement; $f=f_{res}$

Table 5 On-state characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Source-to-source on-state resistance	$R_{SS(on)}$	-	55	70	m Ω	$I_{GS}=30.0\text{ mA}$; $I_{SS}=9\text{ A}$; $T_j=25^\circ\text{C}$
			103	-		$I_{GS}=30.0\text{ mA}$; $I_{SS}=9\text{ A}$; $T_j=150^\circ\text{C}$

Table 6 Dynamic characteristics - switch mode, see Table 10

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance: switch mode	$C_{iss, switch}$	-	346	-	pF	$V_{GS}=0\text{ V}$; $V_{SS}=400\text{ V}$; $f=1\text{ MHz}$
Output capacitance: switch mode	$C_{oss, switch}$		147			
Reverse Transfer capacitance: switch mode	$C_{rss, switch}$		3			
Effective output capacitance, energy related: switch mode ²⁾	$C_{o(er), switch}$	-	166	-	pF	$V_{GS}=0\text{ V}$; $V_{SS}=400\text{ V}$
Effective output capacitance, time related: switch mode ³⁾	$C_{o(tr), switch}$	-	180	-	pF	$V_{GS}=0\text{ V}$; $V_{SS}=0\text{ to }400\text{ V}$; $I_{SS}=\text{const}$
Output charge: switch mode	$Q_{oss, switch}$	-	72	-	nC	$V_{GS}=0\text{ V}$; $V_{SS}=400\text{ V}$

- 2) $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{SS} is rising from 0 to 400 V
- 3) $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{SS} is rising from 0 to 400 V

Table 7 Dynamic characteristics - diode mode, see Table 11

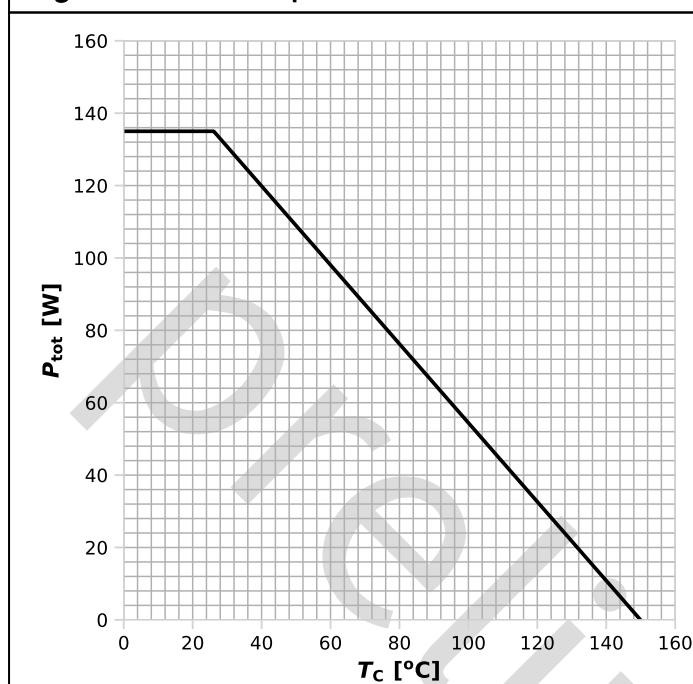
Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance: diode mode	$C_{iss,diode}$	-	351	-	pF	$V_{GxSx}=0\text{ V}; V_{GySy}=3\text{ V}; V_{SySx}=400\text{ V};$ $f=1\text{ MHz}$
Output capacitance: diode mode	$C_{oss,diode}$		172			
Reverse Transfer capacitance: diode mode	$C_{rss,diode}$		4			
Effective output capacitance, energy related: diode mode ⁴⁾	$C_{o(er),diode}$	-	198	-	pF	$V_{GxSx}=0\text{ V}; V_{GySy}=3\text{ V}; V_{SySx}=400\text{ V}$
Effective output capacitance, time related: diode mode ⁵⁾	$C_{o(tr),diode}$	-	224	-	pF	$V_{GxSx}=0\text{ V}; V_{GySy}=3\text{ V};$ $V_{SySx}=0\text{ to }400\text{ V}; I_{SS}=\text{const}$
Output charge: diode mode	$Q_{oss,diode}$	-	90	-	nC	$V_{GxSx}=0\text{ V}; V_{GySy}=3\text{ V}; V_{SySx}=400\text{ V}$

- 4) $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{SS} is rising from 0 to 400 V

- 5) $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{SS} is rising from 0 to 400 V

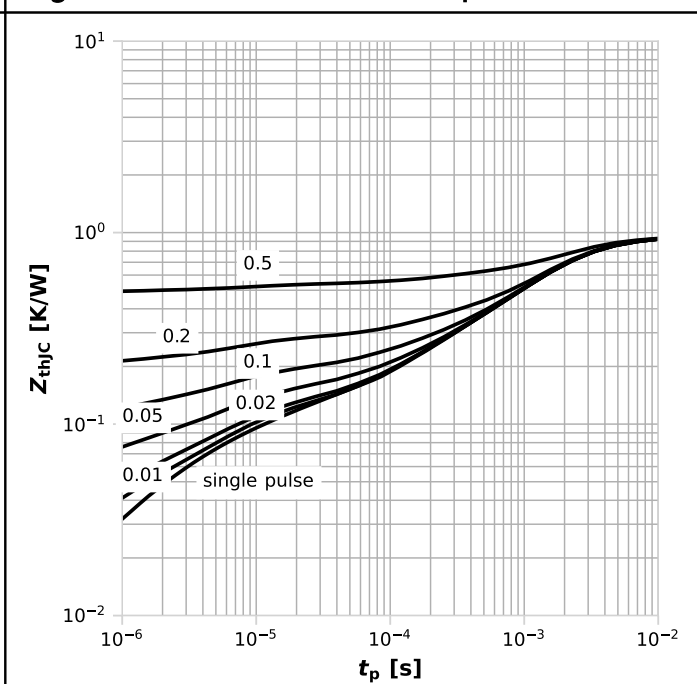
4 Electrical characteristics diagrams

Diagram 1: Power dissipation



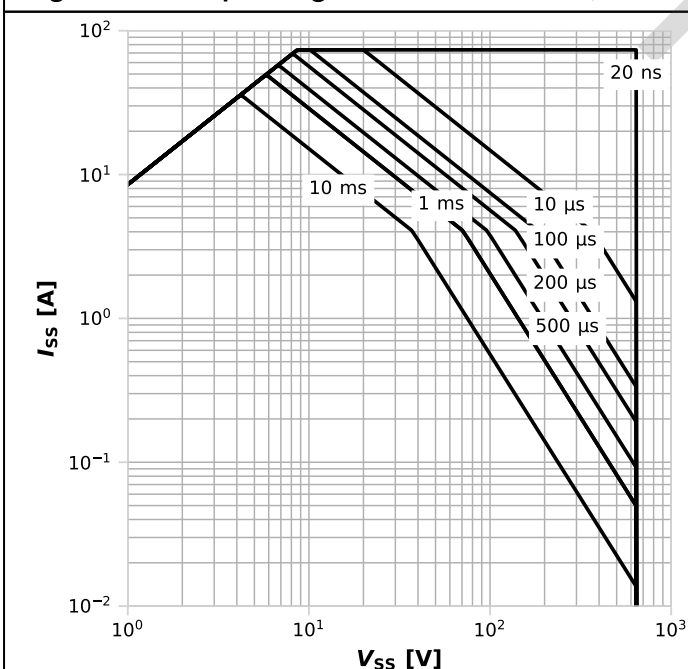
$$P_{\text{tot}} = f(T_c)$$

Diagram 2: Max. transient thermal impedance



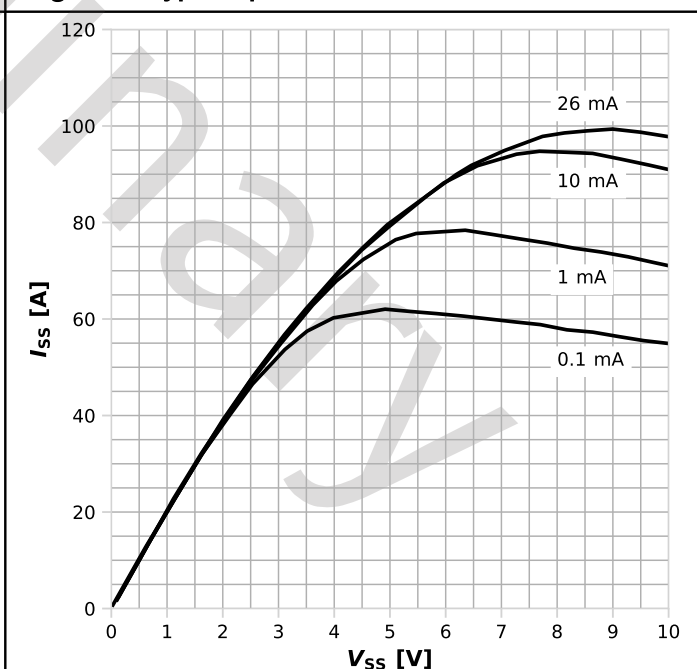
$$Z_{\text{thJC}} = f(t_p); \text{ parameter: } D = t_p / T$$

Diagram 3: Safe operating area



$$I_{\text{SS}} = f(V_{\text{SS}}); T_c = 25^\circ\text{C}; D = 0; \text{ parameter: } t_p$$

Diagram 4: Typ. output characteristics



$$I_{\text{SS}} = f(V_{\text{SS}}); V_{\text{GSy}} = 3 \text{ V}; T_j = 25^\circ\text{C}; \text{ parameter: } I_{\text{GxSx}}$$

Diagram 5: Typ. output characteristics

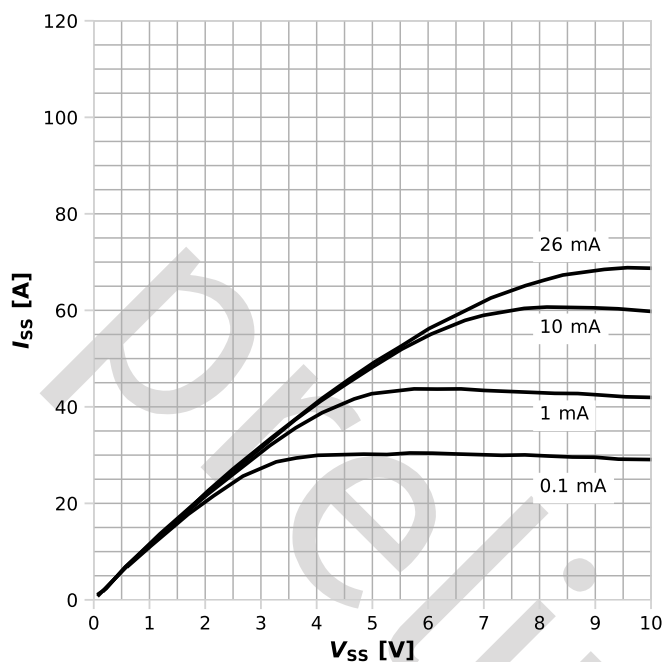

 $I_{SS} = f(V_{SS}); V_{GSy} = 3 \text{ V}; T_j = 125^\circ\text{C}; \text{parameter: } I_{GxSx}$

Diagram 6: Typ. source on-state resistance

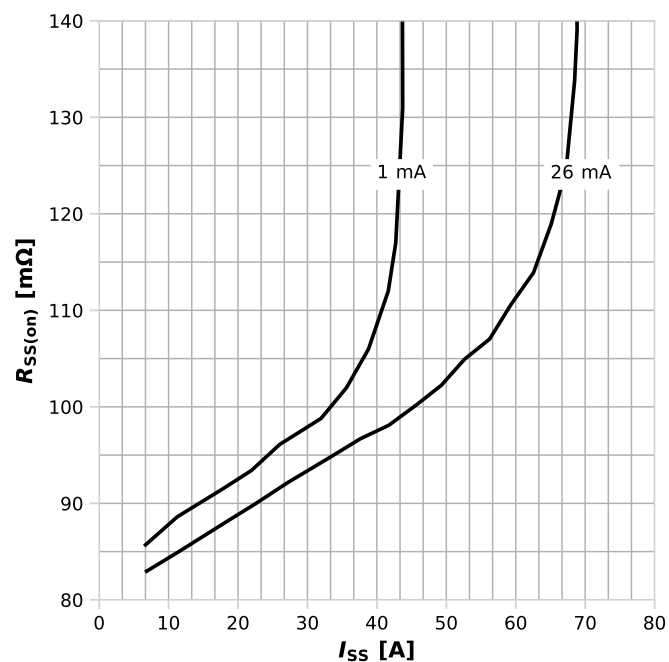

 $R_{SS(on)} = f(I_{SS}); V_{GSy} = 3 \text{ V}; T_j = 125^\circ\text{C}; \text{parameter: } I_{GxSx}$

Diagram 7: Typ. source-source on-state resistance

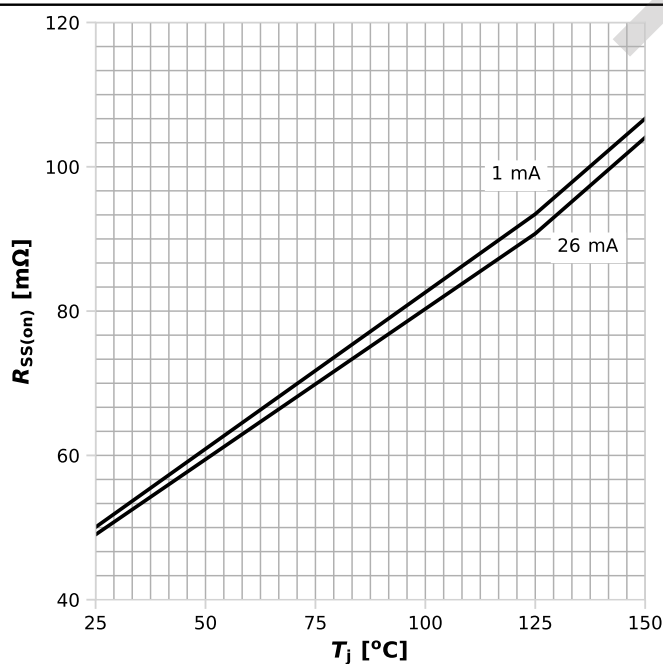

 $R_{SS(on)} = f(T_j); V_{GSy} = 3 \text{ V}; I_{SS} = 20 \text{ A}; \text{parameter: } I_{GxSx}$

Diagram 8: Typ. gate characteristics forward

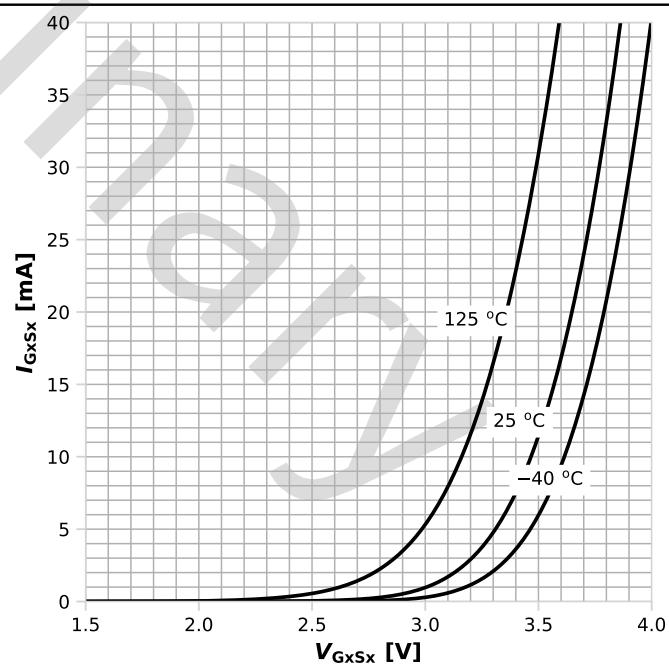
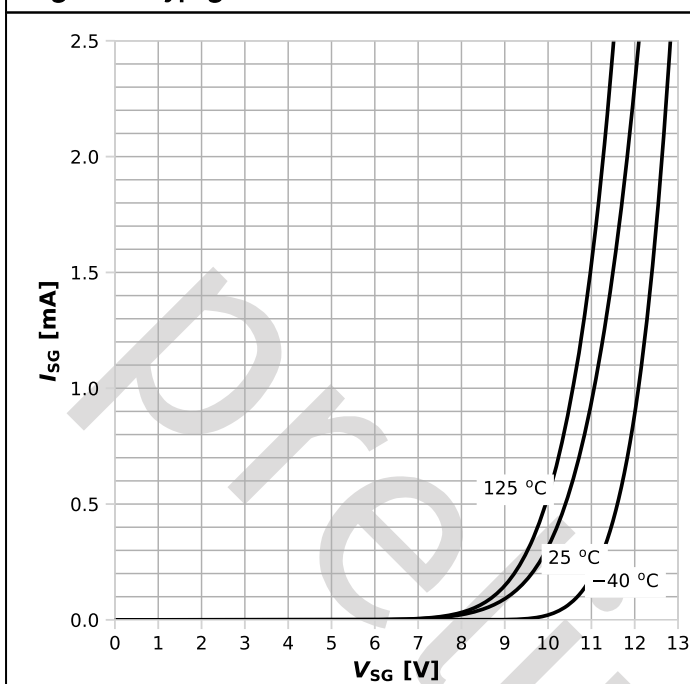
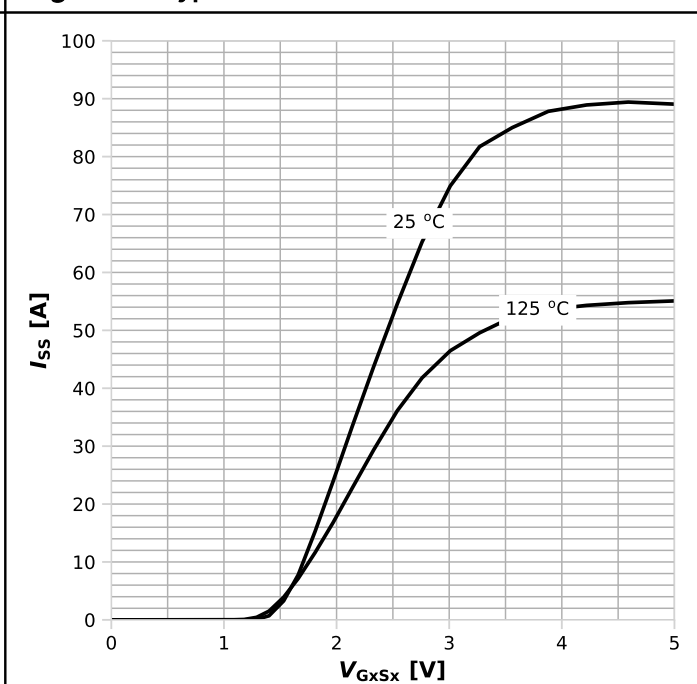

 $I_{GS} = f(V_{GxSx}); \text{open } S_y, G_y; \text{parameter: } T_j$

Diagram 9: Typ. gate characteristics reverse



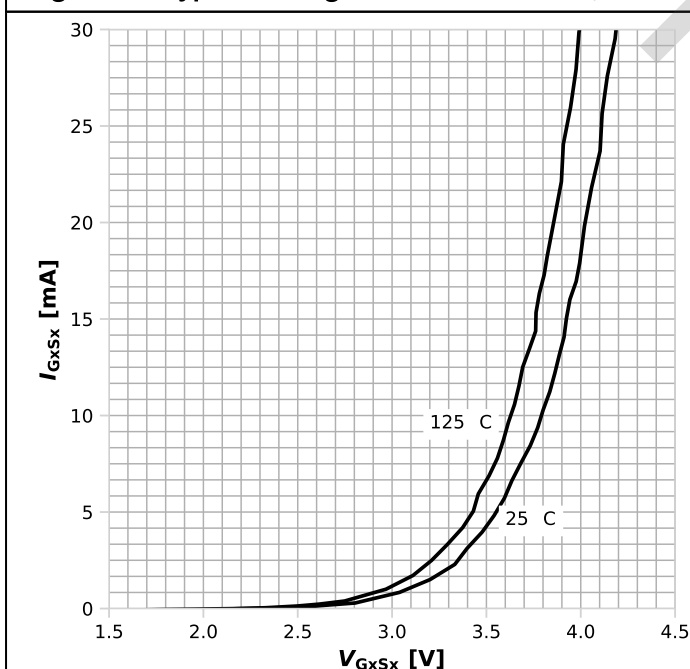
$I_{SG}=f(V_{SG})$; parameter: T_j

Diagram 10: Typ. transfer characteristics



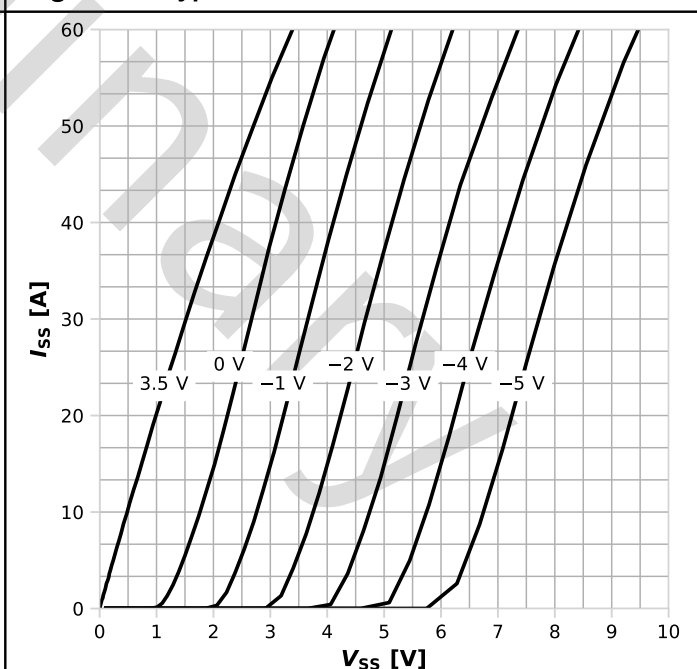
$I_{SS}=f(V_{GxSx})$; $V_{GySy}=3$ V; $V_{SS}=8$ V; parameter: T_j

Diagram 11: Typ. transfer gate current characteristics



$I_{GxSx}=f(V_{GxSx})$; $V_{GySy}=3$ V; $V_{SS}=8$ V; parameter: T_j

Diagram 12: Typ. channel reverse characteristics



$I_{SS}=f(V_{SS})$; $I_{GySy}=37$ mA; $T_j=25$ °C; parameter: V_{GxSx}

Diagram 13: Typ. channel reverse characteristics

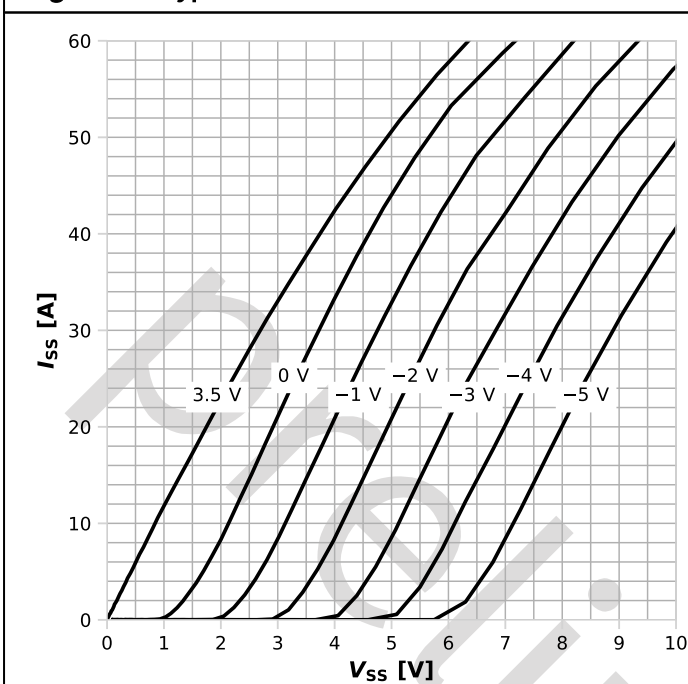

 $I_{SS}=f(V_{SS}); I_{GySy}=37 \text{ mA}; T_j=125^\circ\text{C}; \text{parameter: } V_{GxSx}$

Diagram 14 Typ. gate charge

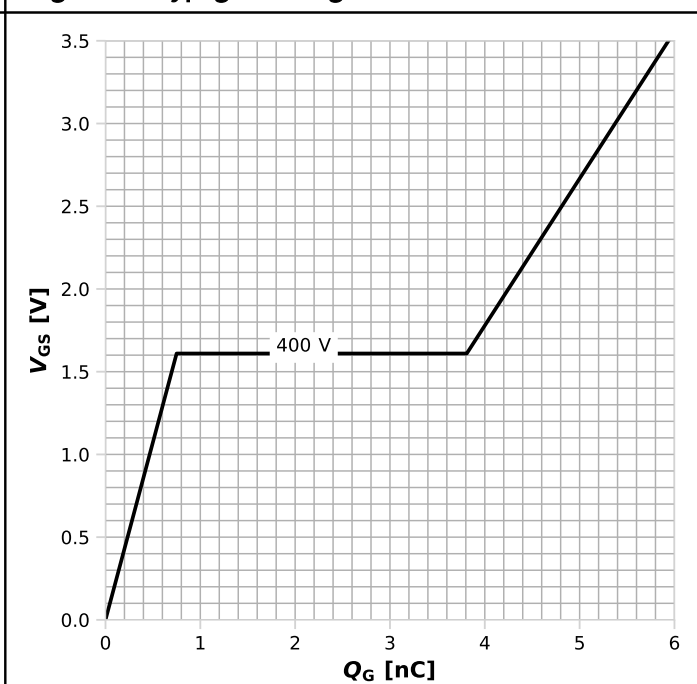

 $V_{GxSx}=f(Q_G); V_{GySy}=3 \text{ V}; I_{SS}=9.3 \text{ A pulsed}; \text{parameter: } V_{SS}$

Diagram 15: Typ. capacitances in switch mode (OFF-OFF)

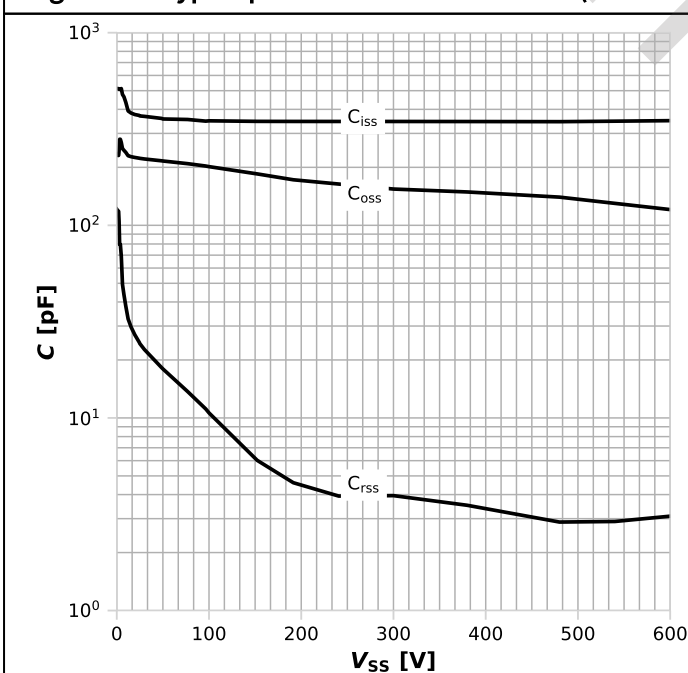

 $C_{zss}=f(V_{SS}); V_{GS}=0 \text{ V}$

Diagram 16: Typ. capacitances in diode mode (ON-OFF)

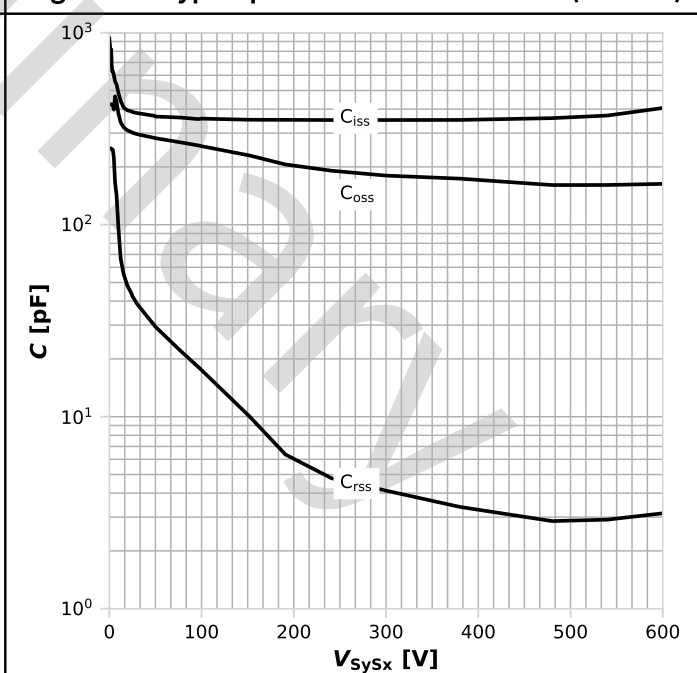

 $C_{zss}=f(V_{SySx}); V_{GySy}=3 \text{ V}; V_{GxSx}=0 \text{ V}$

Diagram 17: Typ. output charge

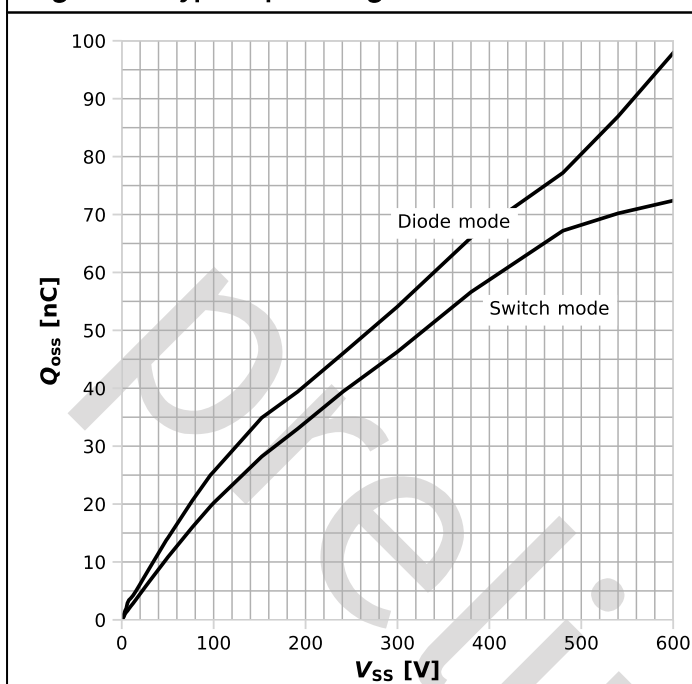
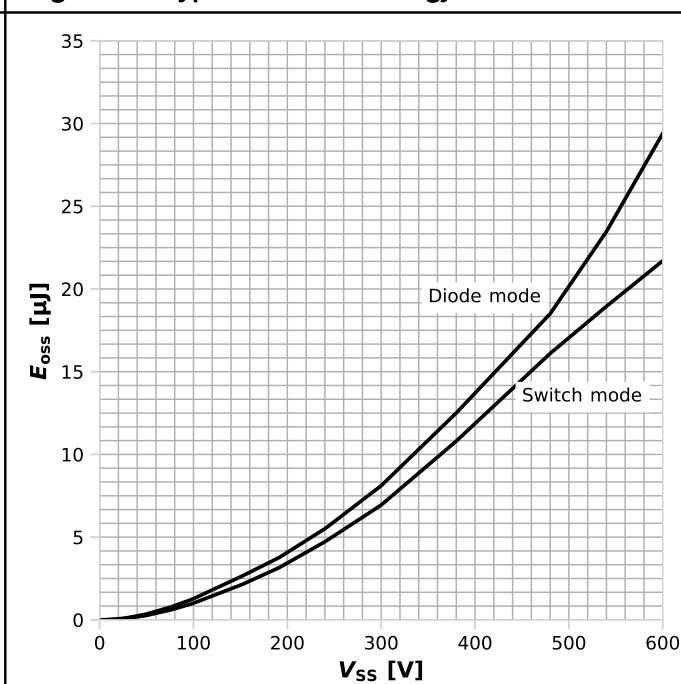
 $Q_{oss}=f(V_{ss});$ parameter: modes

Diagram 18: Typ. Coss stored Energy

 $E_{oss}=f(V_{ss});$ parameter: modes

5 Test circuits

Table 8 Gate current switching waveform

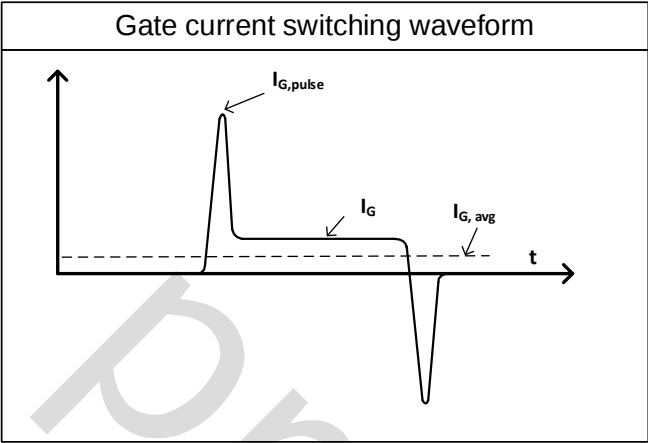
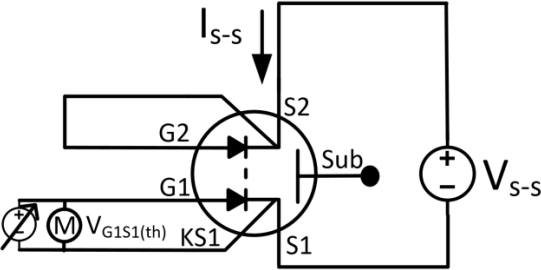
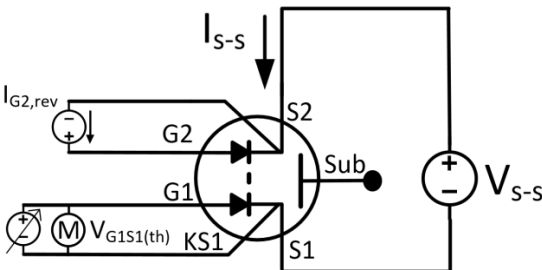


Table 9 Test condition

$V_{GXSX(th)}$ test condition (diode mode)	$V_{GXSX(th)}$ test condition (switch mode)
	

The diagrams show the test setups for the diode and switch modes. Both include a MOSFET (S1) with gate (G1), source (S), and drain (D) terminals, a diode (S2) with anode (A) and cathode (C) terminals, and a substrate (Sub). A current source I_{S-S} is connected between the source and drain. A voltage source V_{S-S} is connected between the source and drain. A diode (KS1) is connected between the gate and source. A voltmeter $V_{G1S1(th)}$ is connected across the gate and source. In the diode mode, the gate is connected to the drain. In the switch mode, the gate is connected to the drain and a reverse current $I_{G2,rev}$ is applied to the gate.

6 Modes of operation

Table 10 Switch mode

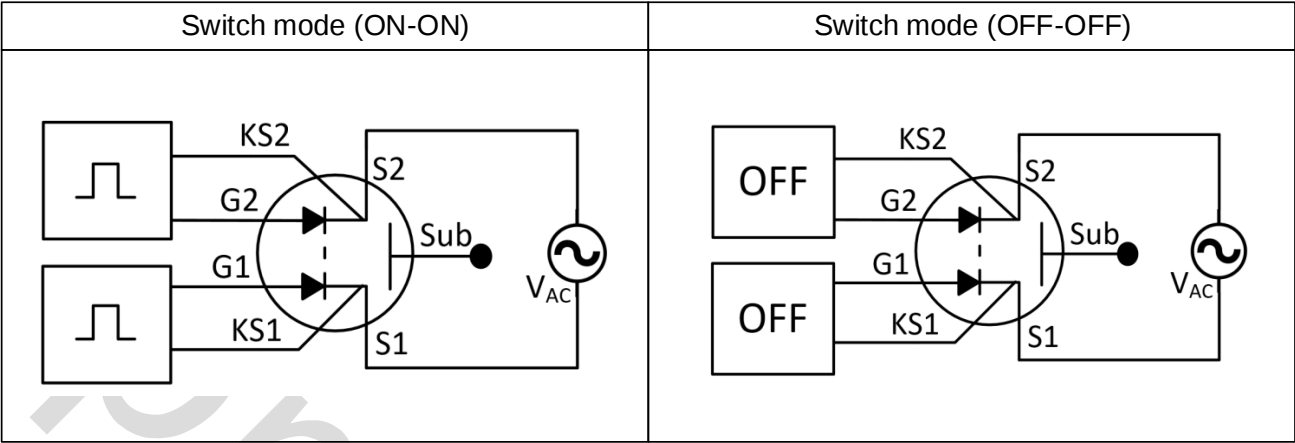
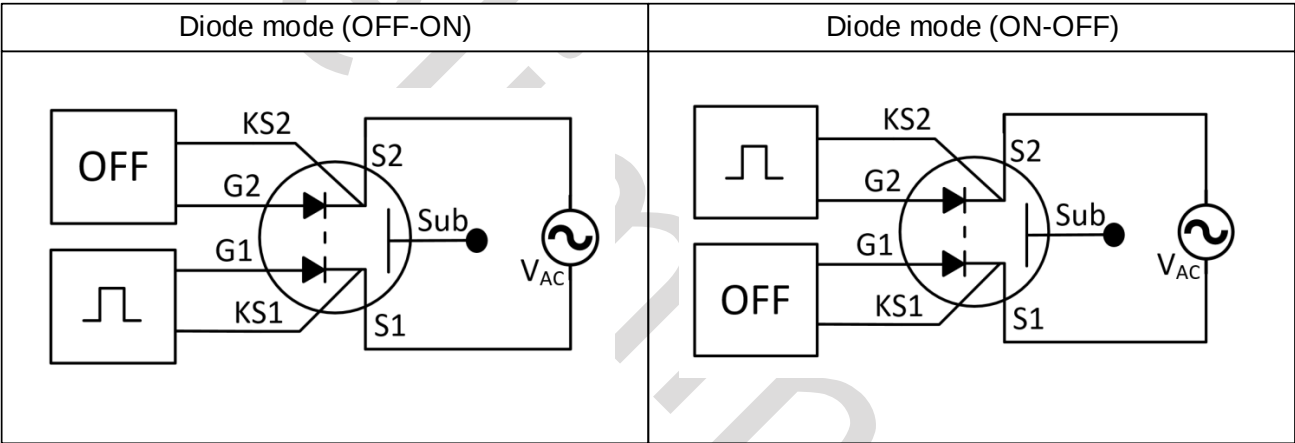
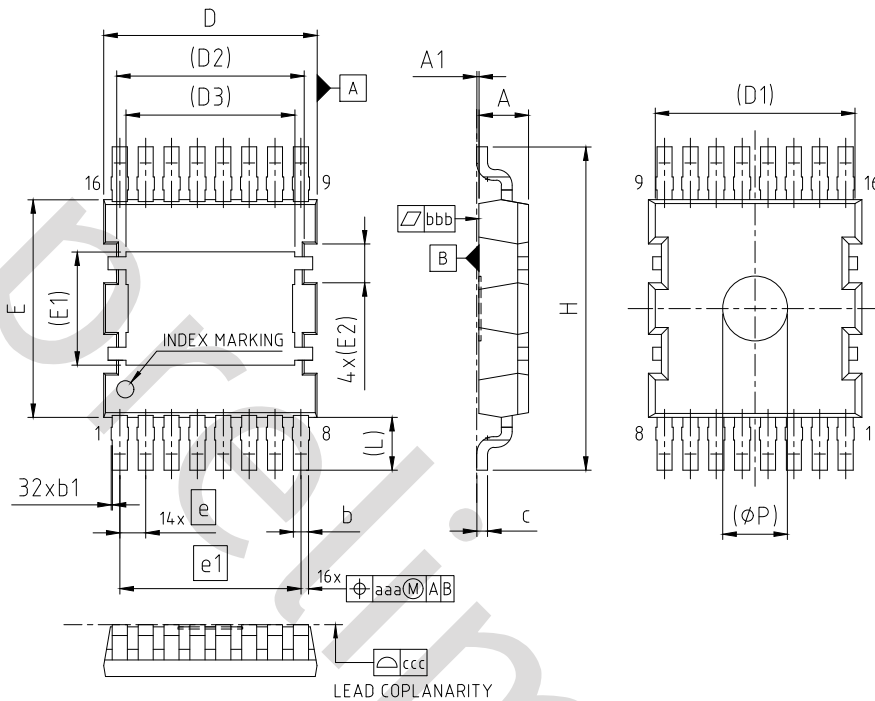


Table 11 Diode mode



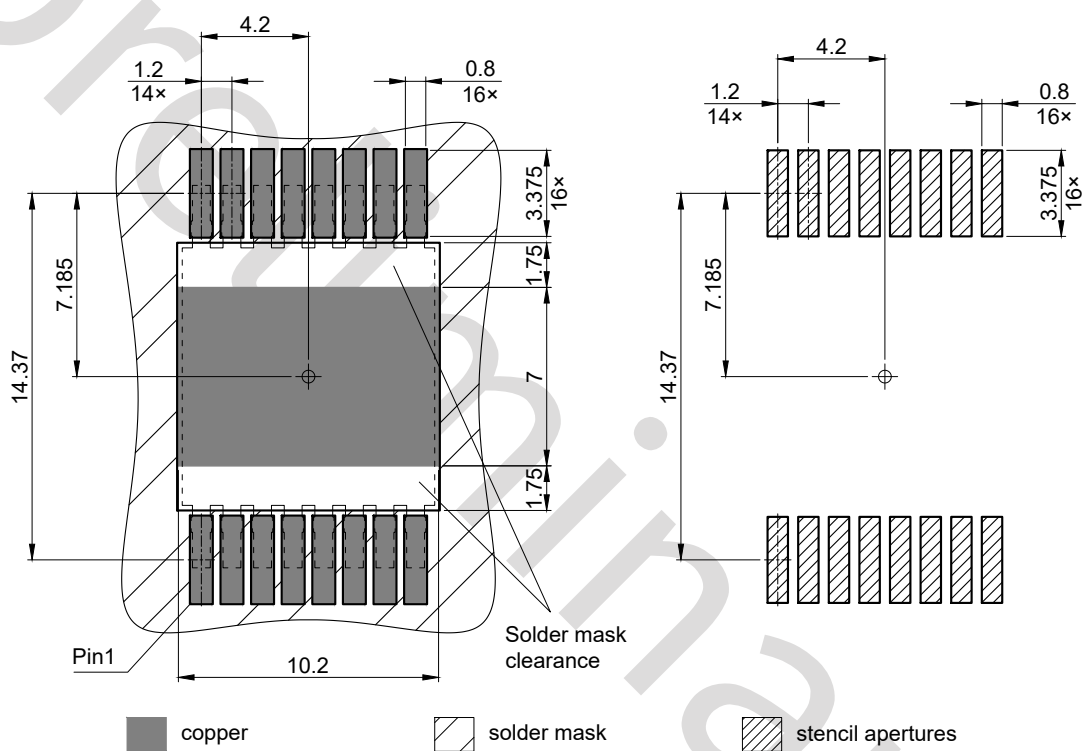
7 Package outlines



PACKAGE - GROUP NUMBER: PG-HDSOP-16-U06					
DIMENSIONS	MILLIMETERS		DIMENSIONS	MILLIMETERS	
	MIN.	MAX.		MIN.	MAX.
A	2.25	2.35	e	1.20	
A1	---	0.15	e1	8.40	
b	0.60	0.80	H	14.80	15.20
b1	---	0.15	L	2.45	
c	0.40	0.60	ØP	3.00	
D	9.70	10.10	aaa	0.25	
D1	9.27		bbb	0.02	
D2	8.70		ccc	0.10	
D3	7.83				
E	10.00	10.30			
E1	5.26				
E2	1.80				

NOTE: DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

Figure 1 Outline PG-HDSOP-16, dimensions in mm



All dimensions are in units mm
Based on stencil thickness 0.2 mm
All pads are non-solder mask defined

Figure 2 Footprint drawing PG-HDSOP-16, dimensions in mm

8 Appendix A

Table 12 **Related links**

- [IFX CoolGaN™ GaN 650 V webpage](#)
- [IFX CoolGaN™ GaN 650 V reliability white paper](#)
- [IFX CoolGaN™ GaN 650 V gate driver application note](#)
- [IFX CoolGaN™ GaN 650 V applications information](#)

Preliminary

Revision history

IGLT65R055B2

Revision 2025-03-18, Rev. 0.1

Previous revisions

Revision	Date	Subjects (major changes since last revision)
0.1	2025-03-18	Release of preliminary

Preliminary

Trademarks

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Please note:

The product is not developed and released for series supply by Infineon.

Subject to the development and release of the product for series supply by Infineon, the technical specifications of the product are set forth in the relevant final product data sheet provided by Infineon.

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